

# Low Power, Low Noise Voltage References with Sink/Source Capability

### ADR360/ADR361/ADR363/ADR364/ADR365/ADR366

#### **FEATURES**

Compact TSOT-23-5 packages Low temperature coefficient

B grade: 9 ppm/°C A grade: 25 ppm/°C

Initial accuracy

B grade: ±3 mV maximum A grade: ±6 mV maximum

Ultralow output noise: 6.8 µV p-p (0.1 Hz to 10 Hz)

Low dropout: 300 mV

Low supply current: 190 µA, Maximum

No external capacitor required Output current: +5 mA/-1 mA

Wide temperature range: -40°C to +125°C

#### **APPLICATIONS**

Battery-powered instrumentations Portable medical instrumentations Data acquisition systems Industrial process controls Automotive

#### **GENERAL DESCRIPTION**

The ADR360/ADR361/ADR363/ADR364/ADR365/ADR366 are precision 2.048 V, 2.5 V, 3.0 V, 4.096 V, 5.0 V, and 3.3 V band gap voltage references that feature low power, high precision in a tiny footprint. Using ADI's patented temperature drift curvature correction techniques, the ADR36x references achieve a low temperature drift of 9 ppm/°C in the TSOT package.

The ADR36x family of micropower, low dropout voltage references provides a stable output voltage from a minimum supply of 300 mV above the output. Their advanced design eliminates the need for external capacitors, which further reduces board space and system cost. The combination of low power operation, small size, and ease of use makes the ADR36x precision voltage references ideally suited for battery-operated applications.

#### PIN CONFIGURATION

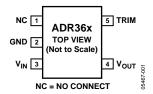


Figure 1. 5-Lead TSOT (UJ Suffix)

Table 1.

Model	<b>V</b> <sub>OUT</sub> <b>(V)</b> <sup>1</sup>	Temperature Coefficient (ppm/°C)	Accuracy (mV)
ADR360B	2.048	9	±3
ADR360A	2.048	25	±6
ADR361B	2.5	9	±3
ADR361A	2.5	25	±6
ADR363B	3.0	9	±3
ADR363A	3.0	25	±6
ADR364B	4.096	9	±4
ADR364A	4.096	25	±8
ADR365B	5.0	9	±4
ADR365A	5.0	25	±8
ADR366B	3.3	9	±4
ADR366A	3.3	25	±8

<sup>&</sup>lt;sup>1</sup> Contact Analog Devices, Inc. for other voltage options.

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### **REVISION HISTORY**

4/05—Revision 0: Initial Version

### ADR360—SPECIFICATIONS

Electrical Characteristics ( $V_{\rm IN}$  = 2.35 V to 15 V,  $T_{\rm A}$  = 25°C, unless otherwise noted.)

Table 2.

Parameter	Symbol	Conditions	Min	Тур	Max	Unit
OUTPUT VOLTAGE	Vo	A Grade	2.042	2.048	2.054	V
	Vo	B Grade	2.045	2.048	2.051	V
INITIAL ACCURACY	V <sub>OERR</sub>	A Grade			6	mV
	$V_{OERR}$	A Grade			0.29	%
	$V_{OERR}$	B Grade			3	mV
	Voerr	B Grade			0.15	%
TEMPERATURE COEFFICIENT	TCVo	A Grade, -40°C < T <sub>A</sub> < +125°C			25	ppm/°C
		B Grade, −40°C < T <sub>A</sub> < +125°C			9	ppm/°C
SUPPLY VOLTAGE HEADROOM	$V_{\text{IN}} - V_{\text{O}}$		300			mV
LINE REGULATION	$\Delta V_{\text{O}}/\Delta V_{\text{IN}}$	$V_{IN} = 2.45 \text{ V to } 15 \text{ V}, -40^{\circ}\text{C} < T_A < +125^{\circ}\text{C}$			0.105	mV/V
LOAD REGULATION	ΔV <sub>O</sub> /ΔI <sub>LOAD</sub>	$I_{LOAD} = 0$ mA to 5 mA, $-40^{\circ}$ C < $T_A$ < $+125^{\circ}$ C, $V_{IN} = 3$ V			0.37	mV/mA
		$I_{LOAD} = -1 \text{ mA to } 0 \text{ mA}, -40^{\circ}\text{C} < T_A < +125^{\circ}\text{C}, V_{IN} = 3 \text{ V}$			0.82	mV/mA
QUIESCENT CURRENT	I <sub>IN</sub>	-40°C < T <sub>A</sub> < +125°C		150	190	μΑ
VOLTAGE NOISE	e <sub>N p-p</sub>	0.1 Hz to 10 Hz		6.8		μV p-p
TURN-ON SETTLING TIME	t <sub>R</sub>			25		μs
LONG-TERM STABILITY <sup>1</sup>	ΔVo	1, 000 Hours		50		ppm
OUTPUT VOLTAGE HYSTERESIS	$\Delta V_{O\_HYS}$			100		ppm
RIPPLE REJECTION RATIO	RRR	$f_{IN} = 60 \text{ kHz}$		70		dB
SHORT CIRCUIT TO GND	I <sub>SC</sub>	$V_{IN} = 5 \text{ V}$		25		mA
		$V_{IN} = 15 \text{ V}$		30		mA

<sup>&</sup>lt;sup>1</sup> The long-term stability specification is noncumulative. The drift subsequent 1,000 hour periods are significantly lower than in the first 1,000 hour period.

### **ADR361—SPECIFICATIONS**

Electrical Characteristics ( $V_{\rm IN}$  = 2.8 V to 15 V,  $T_A$  = 25°C, unless otherwise noted.)

Table 3.

Parameter	Symbol	Conditions	Min	Тур	Max	Unit
OUTPUT VOLTAGE	Vo	A Grade	2.494	2.500	2.506	V
	Vo	B Grade	2.497	2.500	2.503	V
INITIAL ACCURACY	$V_{OERR}$	A Grade			6	mV
	$V_{OERR}$	A Grade			0.24	%
	$V_{OERR}$	B Grade			3	mV
	$V_{OERR}$	B Grade			0.12	%
TEMPERATURE COEFFICIENT	TCVo	A Grade, –40°C < T <sub>A</sub> < +125°C			25	ppm/°C
		B Grade, −40°C < T <sub>A</sub> < +125°C			9	ppm/°C
SUPPLY VOLTAGE HEADROOM	$V_{\text{IN}} - V_{\text{O}}$		300			mV
LINE REGULATION	$\Delta V_{O}/\Delta V_{IN}$	$V_{IN} = 2.8 \text{ V to } 15 \text{ V}, -40^{\circ}\text{C} < T_A < +125^{\circ}\text{C}$			0.125	mV/V
LOAD REGULATION	$\Delta V_{\text{O}}/\Delta I_{\text{LOAD}}$	$I_{LOAD} = 0$ mA to 5 mA, $-40$ °C < $T_A$ < $+125$ °C, $V_{IN} = 3.5$ V			0.45	mV/mA
		$I_{LOAD} = -1 \text{ mA to } 0 \text{ mA}, -40^{\circ}\text{C} < T_A < +125^{\circ}\text{C}, V_{IN} = 3.5 \text{ V}$			1	mV/mA
QUIESCENT CURRENT	I <sub>IN</sub>	-40°C < T <sub>A</sub> < +125°C		150	190	μΑ
VOLTAGE NOISE	ем р-р	0.1 Hz to 10 Hz		8.25		μV p-p
TURN-ON SETTLING TIME	t <sub>R</sub>			25		μs
LONG-TERM STABILITY <sup>1</sup>	ΔVo	1, 000 Hours		50		ppm
OUTPUT VOLTAGE HYSTERESIS	ΔV <sub>O_HYS</sub>			100		ppm
RIPPLE REJECTION RATIO	RRR	f <sub>IN</sub> = 60 kHz		70		dB
SHORT CIRCUIT TO GND	I <sub>SC</sub>	$V_{IN} = 5 \text{ V}$		25		mA
		$V_{IN} = 15 \text{ V}$		30		mA

<sup>&</sup>lt;sup>1</sup> The long-term stability specification is noncumulative. The drift subsequent 1,000 hour periods are significantly lower than in the first 1,000 hour period.

### ADR363—SPECIFICATIONS

Electrical Characteristics (V  $_{\rm IN}$  = 3.3 V to 15 V,  $T_{\rm A}$  = 25 °C, unless otherwise noted.)

Table 4.

Parameter	Symbol	Conditions	Min	Тур	Max	Unit
OUTPUT VOLTAGE	Vo	A Grade	2.994	3.000	3.006	V
	Vo	B Grade	2.997	3.000	3.003	V
INITIAL ACCURACY	$V_{OERR}$	A Grade			6	mV
	$V_{OERR}$	A Grade			0.2	%
	$V_{OERR}$	B Grade			3	mV
	V <sub>OERR</sub>	B Grade			0.1	%
TEMPERATURE COEFFICIENT	TCVo	A Grade, -40°C < T <sub>A</sub> < +125°C			25	ppm/°C
		B Grade, −40°C < T <sub>A</sub> < +125°C			9	ppm/°C
SUPPLY VOLTAGE HEADROOM	$V_{\text{IN}} - V_{\text{O}}$		300			mV
LINE REGULATION	$\Delta V_{\text{O}}/\Delta V_{\text{IN}}$	$V_{IN} = 3.3 \text{ V to } 15 \text{ V}, -40^{\circ}\text{C} < T_A < +125^{\circ}\text{C}$			0.15	mV/V
LOAD REGULATION	ΔV <sub>O</sub> /ΔI <sub>LOAD</sub>	$I_{LOAD} = 0$ mA to 5 mA, $-40^{\circ}$ C $<$ $T_{A}$ $< +125^{\circ}$ C, $V_{IN}$ $= 4$ V			0.54	mV/mA
		$I_{LOAD} = -1 \text{ mA to } 0 \text{ mA}, -40^{\circ}\text{C} < T_A < +125^{\circ}\text{C}, V_{IN} = 4 \text{ V}$			1.2	mV/mA
QUIESCENT CURRENT	I <sub>IN</sub>	-40°C < T <sub>A</sub> < +125°C		150	190	μΑ
VOLTAGE NOISE	е <sub>N р-р</sub>	0.1 Hz to 10 Hz		8.7		μV p-p
TURN-ON SETTLING TIME	t <sub>R</sub>			25		μs
LONG-TERM STABILITY <sup>1</sup>	ΔVο	1, 000 Hours		50		ppm
OUTPUT VOLTAGE HYSTERESIS	ΔV <sub>O_HYS</sub>			100		ppm
RIPPLE REJECTION RATIO	RRR	$f_{IN} = 60 \text{ kHz}$		70		dB
SHORT CIRCUIT TO GND	I <sub>SC</sub>	$V_{IN} = 5 \text{ V}$		25		mA
		$V_{IN} = 15 \text{ V}$		30		mA

<sup>&</sup>lt;sup>1</sup> The long-term stability specification is noncumulative. The drift subsequent 1,000 hour periods are significantly lower than in the first 1,000 hour period.

### **ADR364—SPECIFICATIONS**

Electrical Characteristics ( $V_{\rm IN}$  = 4.4 V to 15 V,  $T_A$  = 25°C, unless otherwise noted.)

Table 5.

Parameter	Symbol	Conditions	Min	Тур	Max	Unit
OUTPUT VOLTAGE	Vo	A Grade	4.088	4.096	4.104	V
	Vo	B Grade	4.092	4.096	4.100	V
INITIAL ACCURACY	V <sub>OERR</sub>	A Grade			8	mV
	$V_{OERR}$	A Grade			0.2	%
	$V_{OERR}$	B Grade			4	mV
	$V_{OERR}$	B Grade			0.1	%
TEMPERATURE COEFFICIENT	TCV <sub>0</sub>	A Grade, -40°C < T <sub>A</sub> < +125°C			25	ppm/°C
		B Grade, −40°C < T <sub>A</sub> < +125°C			9	ppm/°C
SUPPLY VOLTAGE HEADROOM	$V_{\text{IN}} - V_{\text{O}}$		300			mV
LINE REGULATION	$\Delta V_{O}/\Delta V_{IN}$	$V_{IN} = 4.4 \text{ V to } 15 \text{ V}, -40^{\circ}\text{C} < T_A < +125^{\circ}\text{C}$			0.205	mV/V
LOAD REGULATION	ΔV <sub>O</sub> /ΔI <sub>LOAD</sub>	$I_{LOAD} = 0$ mA to 5 mA, $-40^{\circ}$ C $<$ $T_{A}$ $< +125^{\circ}$ C, $V_{IN}$ $= 5$ V			0.735	mV/mA
		$I_{LOAD} = -1 \text{ mA to } 0 \text{ mA}, -40^{\circ}\text{C} < T_A < +125^{\circ}\text{C}, V_{IN} = 5 \text{ V}$			1.75	mV/mA
QUIESCENT CURRENT	I <sub>IN</sub>	-40°C < T <sub>A</sub> < +125°C		150	190	μΑ
VOLTAGE NOISE	e <sub>N p-p</sub>	0.1 Hz to 10 Hz		11		μV p-p
TURN-ON SETTLING TIME	t <sub>R</sub>			25		μs
LONG-TERM STABILITY <sup>1</sup>	ΔVo	1, 000 Hours		50		ppm
OUTPUT VOLTAGE HYSTERESIS	$\Delta V_{O\_HYS}$			100		ppm
RIPPLE REJECTION RATIO	RRR	$f_{IN} = 60 \text{ kHz}$		70		dB
SHORT CIRCUIT TO GND	I <sub>SC</sub>	$V_{IN} = 5 \text{ V}$		25		mA
		$V_{IN} = 15 \text{ V}$		30		mA

<sup>&</sup>lt;sup>1</sup> The long-term stability specification is noncumulative. The drift subsequent 1,000 hour periods are significantly lower than in the first 1,000 hour period.

### ADR365—SPECIFICATIONS

Electrical Characteristics (V  $_{\rm IN}$  = 5.3 V to 15 V,  $T_{\rm A}$  = 25 °C, unless otherwise noted.)

#### Table 6.

Parameter	Symbol	Conditions	Min	Тур	Max	Unit
OUTPUT VOLTAGE	Vo	A Grade	4.992	5.000	5.008	V
	Vo	B Grade	4.996	5.000	5.004	V
INITIAL ACCURACY	V <sub>OERR</sub>	A Grade			8	mV
	$V_{OERR}$	A Grade			0.16	%
	$V_{OERR}$	B Grade			4	mV
	$V_{OERR}$	B Grade			0.08	%
TEMPERATURE COEFFICIENT	TCVo	A Grade, -40°C < T <sub>A</sub> < +125°C			25	ppm/°C
		B Grade, -40°C < T <sub>A</sub> < +125°C			9	ppm/°C
SUPPLY VOLTAGE HEADROOM	$V_{\text{IN}} - V_{\text{O}}$		300			mV
LINE REGULATION	$\Delta V_{\text{O}}/\Delta V_{\text{IN}}$	$V_{IN} = 5.3 \text{ V to } 15 \text{ V}, -40^{\circ}\text{C} < T_A < +125^{\circ}\text{C}$			0.25	mV/V
LOAD REGULATION	ΔV <sub>O</sub> /ΔI <sub>LOAD</sub>	$I_{LOAD} = 0 \text{ mA to 5 mA}, -40^{\circ}\text{C} < T_A < +125^{\circ}\text{C}, V_{IN} = 6\text{V}$			0.9	mV/mA
		$I_{LOAD} = -1 \text{ mA to } 0 \text{ mA}, -40^{\circ}\text{C} < T_A < +125^{\circ}\text{C}, V_{IN} = 6 \text{ V}$			2	mV/mA
QUIESCENT CURRENT	I <sub>IN</sub>	-40°C < T <sub>A</sub> < +125°C		150	190	μΑ
VOLTAGE NOISE	e <sub>N p-p</sub>	0.1 Hz to 10 Hz		12.8		μV p-p
TURN-ON SETTLING TIME	t <sub>R</sub>			20		μs
LONG-TERM STABILITY <sup>1</sup>	ΔVο	1, 000 Hours		50		ppm
OUTPUT VOLTAGE HYSTERESIS	$\Delta V_{O\_HYS}$			100		ppm
RIPPLE REJECTION RATIO	RRR	$f_{IN} = 60 \text{ kHz}$		70		dB
SHORT CIRCUIT TO GND	I <sub>SC</sub>	$V_{IN} = 5 \text{ V}$		25		mA
		$V_{IN} = 15 \text{ V}$		30		mA

<sup>&</sup>lt;sup>1</sup> The long-term stability specification is noncumulative. The drift subsequent 1,000 hour periods are significantly lower than in the first 1,000 hour period.

### ADR366—SPECIFICATIONS

Electrical Characteristics ( $V_{\rm IN}$  = 3.6 V to 15 V,  $T_A$  = 25°C, unless otherwise noted.)

Table 7.

Parameter	Symbol	Conditions	Min	Тур	Max	Unit
OUTPUT VOLTAGE	Vo	A Grade	3.292	3.300	3.308	V
	Vo	B Grade	3.296	3.300	3.304	V
INITIAL ACCURACY	$V_{OERR}$	A Grade			8	mV
	$V_{OERR}$	A Grade			0.25	%
	$V_{OERR}$	B Grade			4	mV
	Voerr	B Grade			0.125	%
TEMPERATURE COEFFICIENT	TCV <sub>0</sub>	A Grade, -40°C < T <sub>A</sub> < +125°C			25	ppm/°C
		B Grade, -40°C < T <sub>A</sub> < +125°C			9	ppm/°C
SUPPLY VOLTAGE HEADROOM	$V_{\text{IN}} - V_{\text{O}}$		300			mV
LINE REGULATION	$\Delta V_{O}/\Delta V_{IN}$	$V_{IN} = 3.6 \text{ V to } 15 \text{ V}, -40^{\circ}\text{C} < T_A < +125^{\circ}\text{C}$			0.165	mV/V
LOAD REGULATION	$\Delta V_{\text{O}}/\Delta I_{\text{LOAD}}$	$I_{LOAD} = 0$ mA to 5 mA, $-40^{\circ}$ C < $T_A$ < $+125^{\circ}$ C, $V_{IN} = 4.2$ V			0.6	mV/mA
		$I_{LOAD} = -1 \text{ mA to } 0 \text{ mA}, -40^{\circ}\text{C} < T_A < +125^{\circ}\text{C}, V_{IN} = 4.2 \text{ V}$			1.35	mV/mA
QUIESCENT CURRENT	I <sub>IN</sub>	-40°C < T <sub>A</sub> < +125°C		150	190	μΑ
VOLTAGE NOISE	e <sub>N p-p</sub>	0.1 Hz to 10 Hz		9.3		μV p-p
TURN-ON SETTLING TIME	t <sub>R</sub>			25		μs
LONG-TERM STABILITY <sup>1</sup>	ΔVo	1, 000 Hours		50		ppm
OUTPUT VOLTAGE HYSTERESIS	$\Delta V_{\text{O\_HYS}}$			100		ppm
RIPPLE REJECTION RATIO	RRR	$f_{IN} = 60 \text{ kHz}$		70		dB
SHORT CIRCUIT TO GND	I <sub>SC</sub>	$V_{IN} = 5 \text{ V}$		25		mA
		$V_{IN} = 15 V$		30		mA

<sup>&</sup>lt;sup>1</sup> The long-term stability specification is noncumulative. The drift subsequent 1,000 hour periods are significantly lower than in the first 1,000 hour period.

### **ABSOLUTE MAXIMUM RATINGS**

@ 25°C, unless otherwise noted.

#### Table 8.

Parameter	Rating
Supply Voltage	18 V
Output Short-Circuit Duration to GND	
$V_{IN} < 15 \text{ V}$	Indefinite
$V_{IN} > 15 V$	10 sec
Storage Temperature Range	−65°C to +125°C
Operating Temperature Range	-40°C to +125°C
Junction Temperature Range	−65°C to +125°C
Lead Temperature Range (Soldering, 60 sec)	300°C

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

#### THERMAL RESISTANCE

 $\theta_{JA}$  is specified for the worst-case conditions, that is,  $\theta_{JA}$  is specified for device soldered in circuit board for surface-mount packages.

**Table 9. Thermal Resistance** 

Package Type	θ <sub>JA</sub>	θ <sub>JC</sub>	Unit
TSOT-23-5 (UJ-5)	230	146	°C/W

#### **ESD CAUTION**

ESD (electrostatic discharge) sensitive device. Electrostatic charges as high as 4000 V readily accumulate on the human body and test equipment and can discharge without detection. Although this product features proprietary ESD protection circuitry, permanent damage may occur on devices subjected to high energy electrostatic discharges. Therefore, proper ESD precautions are recommended to avoid performance degradation or loss of functionality.



### **TERMINOLOGY**

#### **Temperature Coefficient**

The change of output voltage with respect to operating temperature changes normalized by the output voltage at 25°C. This parameter is expressed in ppm/°C and can be determined by

$$TCV_{O}[ppm/^{\circ}C] = \frac{V_{O}(T_{2}) - V_{O}(T_{1})}{V_{O}(25^{\circ}C) \times (T_{2} - T_{1})} \times 10^{6}$$

where:

 $V_O$  (25°C) =  $V_O$  at 25°C.

 $V_O(T_1) = V_O$  at Temperature 1.

 $V_O(T_2) = V_O$  at Temperature 2.

#### Line Regulation

The change in output voltage due to a specified change in input voltage. This parameter accounts for the effects of self-heating. Line regulation is expressed in either percent per volt, partsper-million per volt, or microvolts per volt change in input voltage.

#### **Load Regulation**

The change in output voltage due to a specified change in load current. This parameter accounts for the effects of self-heating. Load regulation is expressed in either microvolts per milliampere, parts-per-million per milliampere, or ohms of dc output resistance.

#### **Long-Term Stability**

Typical shift of output voltage at 25°C on a sample of parts subjected to a test of 1,000 hours at 25°C.

$$\Delta V_{\rm O} = V_{\rm O}(t_0) - V_{\rm O}(t_1)$$

$$\Delta V_O[ppm] = \left(\frac{V_O(t_0) - V_O(t_1)}{V_O(t_0)} \times 10^6\right)$$

where:

 $V_O(t_0) = V_O$  at 25°C at Time 0.

 $V_O(t_1) = V_O$  at 25°C after 1,000 hours operation at 25°C.

#### Thermal Hysteresis

The change of output voltage after the device is cycled through temperature from  $+25^{\circ}$ C to  $-40^{\circ}$ C to  $+125^{\circ}$ C and back to  $+25^{\circ}$ C. This is a typical value from a sample of parts put through such a cycle.

$$V_{O\_HYS} = V_O(25^{\circ}\text{C}) - V_{O\_TC}$$

$$V_{O\_HYS}[ppm] = \frac{V_O(25^{\circ}C) - V_{O\_TC}}{V_O(25^{\circ}C)} \times 10^6$$

where:

 $V_O$  (25°C) =  $V_O$  at 25°C.

 $V_{O\_TC} = V_O$  at 25°C after temperature cycle at +25°C to -40°C to +125°C and back to +25°C.

#### **NOTES**

#### **Input Capacitor**

Input capacitors are not required on the ADR36x. There is no limit for the value of the capacitor used on the input, but a 1  $\mu F$  to 10  $\mu F$  capacitor on the input improves transient response in applications where the supply suddenly changes. An additional 0.1  $\mu F$  capacitor in parallel also helps reduce noise from the supply.

#### **Output Capacitor**

The ADR36x does not require output capacitors for stability under any load condition. An output capacitor, typically 0.1  $\mu F_s$  filters out any low level noise voltage and does not affect the operation of the part. On the other hand, the load transient response can improve with an additional 1  $\mu F$  to 10  $\mu F$  output capacitor in parallel. A capacitor here acts as a source of stored energy for a sudden increase in load current. The only parameter that degrades by adding an output capacitor is the turn-on time. The degradation depends on the size of the capacitor chosen.

### TYPICAL PERFORMANCE CHARACTERISTICS

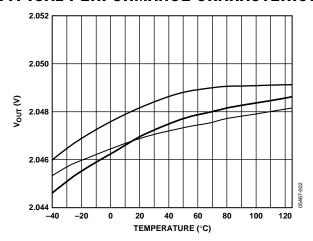


Figure 2. ADR360 Output Voltage vs. Temperature

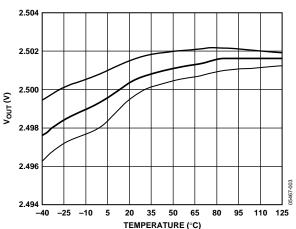


Figure 3. ADR361 Output Voltage vs. Temperature

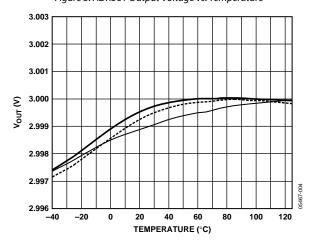


Figure 4. ADR363 Output Voltage vs. Temperature

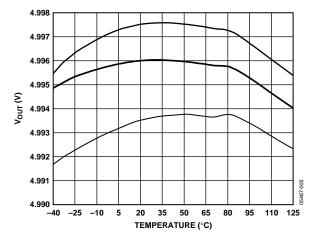


Figure 5. ADR365 Output Voltage vs. Temperature

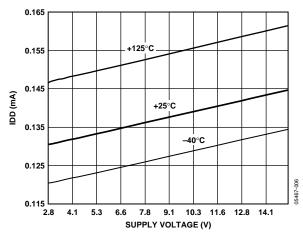


Figure 6. ADR361 Supply Current vs. Input Voltage

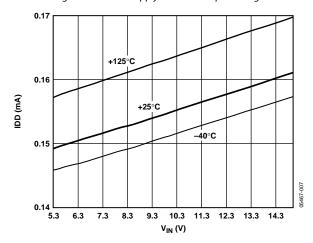


Figure 7. ADR365 Supply Current vs. Input Voltage

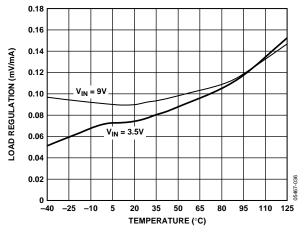


Figure 8. ADR361 Load Regulation vs. Temperature

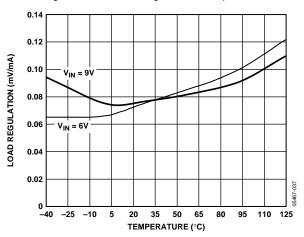


Figure 9. ADR365 Load Regulation vs. Temperature

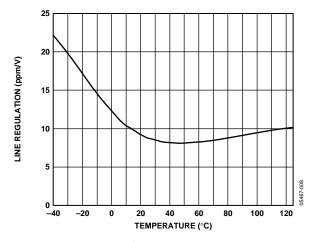


Figure 10. ADR360 Line Regulation vs. Temperature,  $V_{\text{IN}}$  = 2.45 V to 15 V

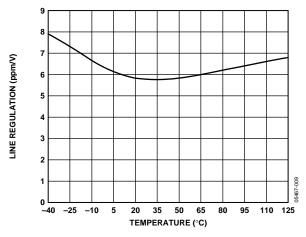


Figure 11. ADR361 Line Regulation vs. Temperature,  $V_{IN} = 2.8 \text{ V}$  to 15 V

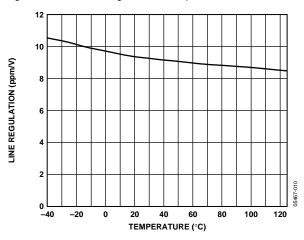


Figure 12. ADR365 Line Regulation vs. Temperature,  $V_{IN} = 5.3 \text{ V}$  to 15 V

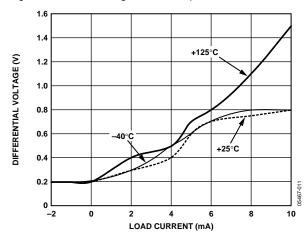


Figure 13. ADR361 Minimum Input Voltage vs. Load Current

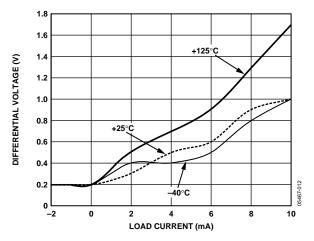


Figure 14. ADR365 Minimum Input Voltage vs. Load Current

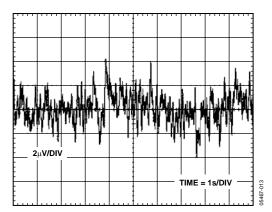


Figure 15. ADR361 Minimum Input Voltage vs. Load Current

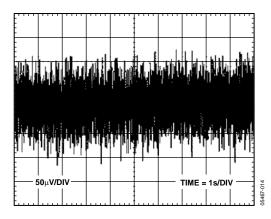


Figure 16. ADR361 10 Hz to 10 kHz Noise

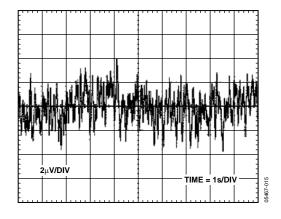


Figure 17. ADR363 0.1 Hz to 10 kHz Noise

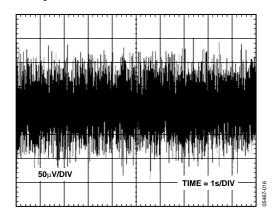


Figure 18. ADR363 10 Hz to 10 kHz Noise

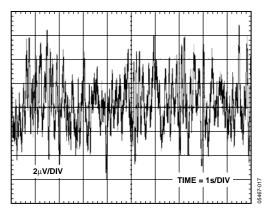


Figure 19. ADR365 0.1 Hz to 10 Hz Noise

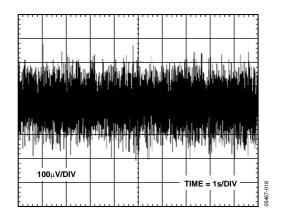


Figure 20. ADR365 10 Hz to 10 kHz Noise

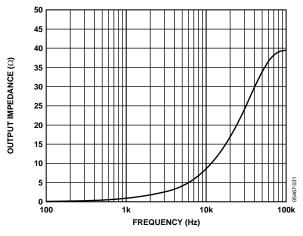


Figure 21. Voltage Noise Density vs. Frequency

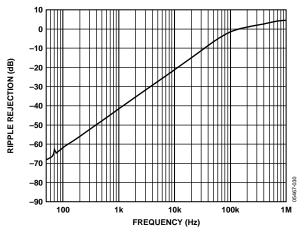


Figure 22. Ripple Rejection Ratio

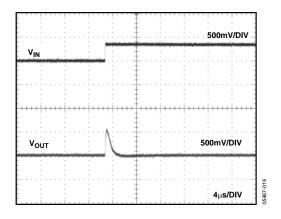


Figure 23. ADR361 Line Transient Response (Increasing), No Capacitors

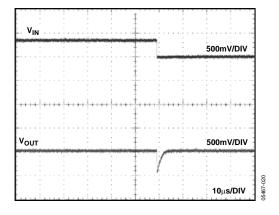


Figure 24. ADR361 Line Transient Response (Decreasing), No Capacitors

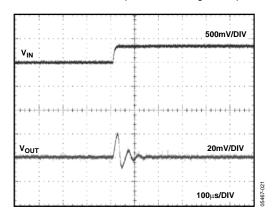


Figure 25. ADR361 Line Transient Response, 0.1 μF Input Capacitor

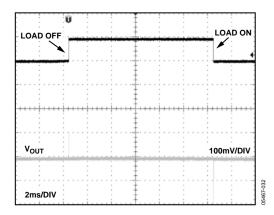


Figure 26. ADR361 Load Transient Response

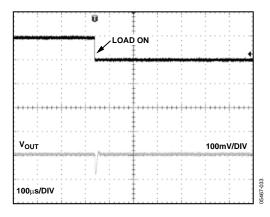


Figure 27. ADR361 Load Transient Response, 0.1 μF Input, Output Capacitor

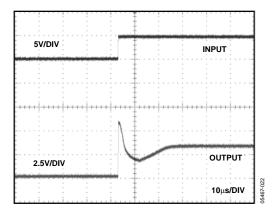


Figure 28. ADR361 Turn-On Response Time at 5 V

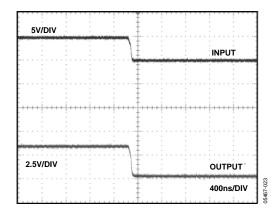


Figure 29. ADR361 Turn-Off Response at 5 V

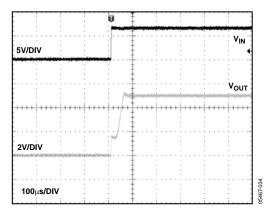


Figure 30. ADR361 Turn-On Response, 0.1 μF Output Capacitor

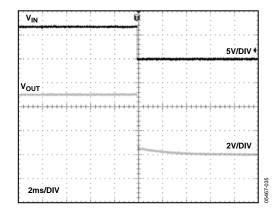


Figure 31. ADR361 Turn-Off Response, 0.1 μF Output Capacitor

### THEORY OF OPERATION

Band gap references are the high performance solution for low supply voltage and low power voltage reference applications, and the ADR36x family is no exception. The uniqueness of these products lies in their architecture. The ideal zero TC band gap voltage is referenced to the output not to ground (see Figure 32). Therefore, if noise exists on the ground line, it is greatly attenuated on  $V_{\text{OUT}}$ . The band gap cell consists of the PNP pair Q51 and Q52 running at unequal current densities. The difference in  $V_{\text{BE}}$  results in a voltage with a positive TC, which is amplified by a ratio of

$$2 \times \frac{R58}{R54}$$

This PTAT voltage, combined with the V<sub>BES</sub> of Q51 and Q52, produces the stable band gap voltage.

Reduction in the band gap curvature is performed by the ratio of the resistors R44 and R59, one of which is linearly temperature dependent. Precision laser trimming and other patented circuit techniques are used to further enhance the drift performance.

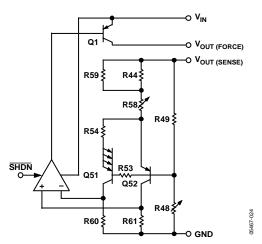


Figure 32. Simplified Schematic

#### **Device Power Dissipation Considerations**

The ADR36x family is capable of delivering load currents to 5 mA with an input voltage that ranges from 2.348 V (ADR360 only) to 18 V. When this device is used in applications with large input voltages, care should be taken to avoid exceeding the specified maximum power dissipation or junction temperature because it could result in premature device failure. Use the following formula to calculate a device's maximum junction temperature or dissipation:

$$P_D = \frac{T_J - T_A}{\theta_{IA}}$$

In this equation,  $T_J$  and  $T_A$  are, respectively, the junction and ambient temperatures,  $P_D$  is the device power dissipation, and  $\theta_{JA}$  is the device package thermal resistance.

### **APPLICATIONS**

#### **BASIC VOLTAGE REFERENCE CONNECTION**

The circuit in Figure 33 illustrates the basic configuration for the ADR36x family. Decoupling capacitors are not required for circuit stability. The ADR36x family is capable of driving capacitive loads from 0  $\mu$ F to 10  $\mu$ F. However, a 0.1  $\mu$ F ceramic output capacitor is recommended to absorb and deliver the charge as is required by a dynamic load.

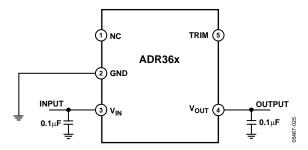


Figure 33. Basic Configuration for the ADR36x Family

#### Stacking Reference ICs for Arbitrary Outputs

Some applications may require two reference voltage sources, which are a combined sum of standard outputs. Figure 34 shows how this stacked output reference can be implemented.

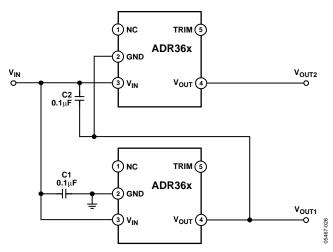


Figure 34. Stacking Voltage References with the ADR36x

Two reference ICs are used, and fed from an unregulated input,  $V_{\rm IN}$ . The outputs of the individual ICs are connected in series, which provides two output voltages,  $V_{\rm OUT1}$  and  $V_{\rm OUT2}$ .  $V_{\rm OUT1}$  is the terminal voltage of U1, while  $V_{\rm OUT2}$  is the sum of this voltage and the terminal voltage of U2. U1 and U2 are chosen for the two voltages that supply the required outputs (see Table 10). For example, if both U1 and U2 are ADR361s,  $V_{\rm OUT1}$  is 2.5 V and  $V_{\rm OUT2}$  is 5.0 V.

Table 10. Output

U1/U2	V <sub>OUT1</sub>	V <sub>OUT2</sub>
ADR361/ADR365	2.5	7.5
ADR361/ADR361	2.5	5.0
ADR365/ADR361	5	7.5

# A Negative Precision Reference Without Precision Resistors

A negative reference is easily generated by adding an op amp, A1, and is configured in Figure 35.  $V_{\text{OUTF}}$  and  $V_{\text{OUTF}}$  are at virtual ground and, therefore, the negative reference can be taken directly from the output of the op amp. The op amp must be dual-supply, low offset, and rail-to-rail if the negative supply voltage is close to the reference output.

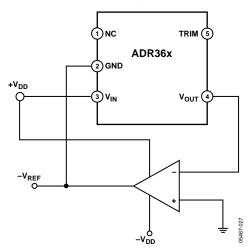


Figure 35. Negative Reference

#### **General Purpose Current Source**

Many times in low power applications, the need arises for a precision current source that can operate on low supply voltages. The ADR36x can be configured as a precision current source (see Figure 36). The circuit configuration illustrated is a floating current source with a grounded load. The reference's output voltage is bootstrapped across  $R_{\text{SET}}$ , which sets the output current into the load. With this configuration, circuit precision is maintained for load currents ranging from the reference's supply current, typically  $150~\mu\text{A}$ , to approximately 5~mA.

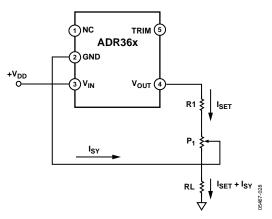


Figure 36. Precision Current Source

#### **Trim Terminal**

The ADR36x trim terminal can be used to adjust the output voltage over a nominal voltage. This feature allows a system designer to trim system errors by setting the reference to a voltage other than the standard voltage option. The resistor R1 is used for fine adjustment and can be omitted if desired. The resistor values should be carefully chosen to ensure that the maximum current drive of the part is not exceeded.

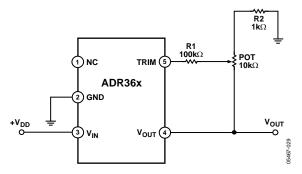
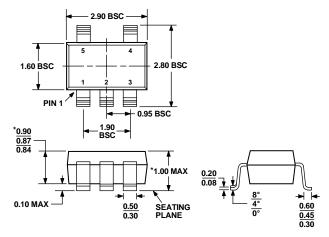


Figure 37. ADR36x Trim Configuration

### **OUTLINE DIMENSIONS**



\*COMPLIANT TO JEDEC STANDARDS MO-193-AB WITH THE EXCEPTION OF PACKAGE HEIGHT AND THICKNESS.

Figure 38. 5-Lead Thin Small Outline Transistor Package [TSOT] (UJ-5) Dimensions shown in millimeters

#### **ORDERING GUIDE**

	Output Voltage	Initial A	ccuracy	Temperature Coefficient	Package	Package	Temperature	
Models*	( <b>V</b> <sub>0</sub> )	(mV)	(%)	(ppm/°C)	Description	Option	Range	Branding
ADR360AUJZ-REEL7 <sup>1</sup>	2.048	6	0.29	25	TSOT	UJ-5	-40°C to +125°C	R0C
ADR360BUJZ-REEL7 <sup>1</sup>	2.048	3	0.15	9	TSOT	UJ-5	-40°C to +125°C	ROD
ADR361AUJZ-REEL71	2.5	6	0.24	25	TSOT	UJ-5	-40°C to +125°C	ROE
ADR361BUJZ-REEL7 <sup>1</sup>	2.5	3	0.12	9	TSOT	UJ-5	−40°C to +125°C	ROF
ADR363AUJZ-REEL7 <sup>1</sup>	3.0	6	0.2	25	TSOT	UJ-5	-40°C to +125°C	R0G
ADR363BUJZ-REEL7 <sup>1</sup>	3.0	3	0.1	9	TSOT	UJ-5	-40°C to +125°C	ROH
ADR364AUJZ-REEL7 <sup>1</sup>	4.096	8	0.2	25	TSOT	UJ-5	-40°C to +125°C	ROJ
ADR364BUJZ-REEL7 <sup>1</sup>	4.096	4	0.1	9	TSOT	UJ-5	-40°C to +125°C	ROK
ADR365AUJZ-REEL7 <sup>1</sup>	5.0	8	0.16	25	TSOT	UJ-5	-40°C to +125°C	ROL
ADR365BUJZ-REEL7 <sup>1</sup>	5.0	4	0.08	9	TSOT	UJ-5	-40°C to +125°C	ROM
ADR366AUJZ-REEL71	3.3	8	0.25	25	TSOT	UJ-5	-40°C to +125°C	R08
ADR366BUJZ-REEL7 <sup>1</sup>	3.3	4	0.125	9	TSOT	UJ-5	-40°C to +125°C	R09

<sup>&</sup>lt;sup>1</sup> Z = Pb-free part

<sup>\*3,000</sup> pieces per reel

IDDAAA/IDDAAA	II D D A A A II D D A A I I	I B B A A E / I B B A A A
A111)つに11/A111)つに1	/ADR363/ADR364/	(人いりつにん/人いりつにに
AIIR JOII/ AIIR JO I	/AIIR.3N.3/AIIR.3N4/	AllK.in:1/AllK.inn

NOTES

